EAST Search History

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|----------|------|---|---|---------------------|---------|------------------|
| L10 | 1040 | (438/95).CCLS. | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/29 15:13 |
| L11 | 34 | 10 and (@pd>"20060101") | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/29 15:34 |
| L12 | 1288 | (438/102).CCLS. | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/29 15:33 |
| L13 | 15 | 12 and (@pd>"20060101") | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/29 15:34 |
| L14 | 1026 | ((resist\$4 near5 variable) (chalcogenide near2 glass)) and electrode and (metal near3 contain\$4) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/29 15:39 |
| L15 | 884 | 14 and voltage | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/29 15:39 |
| L16 | 314 | 15 and memory | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/29 15:47 |
| L17 | 3 | ("6813178").PN. | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/29 15:47 |

EAST Search History

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|----------|------|---|----------|---------------------|---------|------------------|
| L7 | 2 | (electrode and (resist\$4 near2 variable near2 material) and (metal adj contain\$3) and (conduct\$3 near2 channel) and (condition\$3 near2 voltage)).clm. | US-PGPUB | OR | ON | 2006/08/29 17:25 |